

December 2014

# **FCP104N60F**

# N-Channel SuperFET<sup>®</sup> II FRFET<sup>®</sup> MOSFET 600 V, 37 A, 104 m $\Omega$

### **Features**

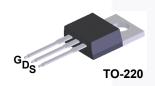
- 650 V @ T<sub>J</sub> = 150°C
- Typ. R<sub>DS(on)</sub> = 91 mΩ
- Ultra Low Gate Charge (Typ.  $Q_g = 110 \text{ nC}$ )
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 313 pF)
- 100% Avalanche Tested

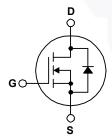
# **Applications**

- · Lighting
- · Solar Inverter
- AC-DC Power Supply

# Description

SuperFET® II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications. SuperFET® II FRFET® MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.





# **MOSFET Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol		Parameter		FCP104N60F	Unit	
V <sub>DSS</sub>	Drain to Source Voltage			600	V	
.,	Cata ta Causaa Maltaga	- DC		±20	V	
$V_{GSS}$	Gate to Source Voltage	- AC	(f > 1Hz)	±30	V	
	Drain Current	- Continuous (T <sub>C</sub> = 25°C)		37	_	
ID	Drain Current	- Continuous (T <sub>C</sub> = 100°C)		24	A	
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	114	Α	
E <sub>AS</sub>	Single Pulsed Avalanche En	ergy	(Note 2)	809	mJ	
I <sub>AR</sub>	Avalanche Current (Note 1)		(Note 1)	6.8	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy (N		(Note 1)	3.57	mJ	
al / al#	Peak Diode Recovery dv/dt		(Note 3)	50	1//	
dv/dt	MOSFET dv/dt			100	V/ns	
n	Davies Dissination	(T <sub>C</sub> = 25°C)		357	W	
$P_{D}$	Power Dissipation	- Derate Above 25°C		2.85	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temp	perature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	οС	

### **Thermal Characteristics**

Symbol	Parameter FCP104N60F			
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.35	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ,Max.	62.5	°C/VV	

# **Package Marking and Ordering Information**

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FCP104N60F	FCP104N60F	TO220	Tube	N/A	N/A	50 units

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted. Parameter

Symbol	Parameter		Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics						
D\/	Drain to Source Breakdown Voltage		$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$	600	-	-	V
BV <sub>DSS</sub> Drain to Source Breakdown Voltage		$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 150^{\circ}\text{C}$	650	-	-	V	
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient		I <sub>D</sub> = 10 mA, Referenced to 25°C	-	0.67	-	V/°C
BV <sub>DS</sub>	Drain-Source Avlanche Breakdown age	Volt-	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 18.5 A	-	700	-	V
	Zoro Cata Voltago Drain Current		V <sub>DS</sub> = 600V, V <sub>GS</sub> = 0 V	-	-	10	
IDSS	Zero Gate Voltage Drain Current		V <sub>DS</sub> = 480 V, T <sub>C</sub> = 125°C	-	16	-	μА
I <sub>GSS</sub>	Gate to Body Leakage Current		V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	-	-	±100	nA

### On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3	-	5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 18.5 \text{ A}$	-	91	104	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 20 \text{ V}, I_{D} = 18.5 \text{ A}$	-	33	-	S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05 V V 0 V	- \	4610	6130	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V f = 1 MHz		3255	4330	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			155	235	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 380 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	74	-	pF
Coss eff.	Effective Output Capacitance	$V_{DS}$ = 0 V to 480 V, $V_{GS}$ = 0 V	-	313	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		-	110	145	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	V <sub>DS</sub> = 380 V, I <sub>D</sub> = 18.5 A	-	24	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	$V_{GS} = 10 \text{ V}$ (Note 4)	-	44	-	nC
ESR	Equivalent Series Resistance	Drain open		0.9		Ω

### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	34	78	ns
t <sub>r</sub>		$V_{DD} = 380 \text{ V}, I_{D} = 18.5 \text{ A}$	/ -	20	50	ns
$t_{d(off)}$	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 4.7 $\Omega$	-	102	214	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)	-	5.7	21.4	ns

### **Drain-Source Diode Characteristics**

$I_S$	Maximum Continuous Drain to Source Dio	Maximum Continuous Drain to Source Diode Forward Current			37	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-		114	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 18.5 A	- ,	-	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 18.5 A	-	144	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	0.91	-	μС

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2.  $I_{AS}$  = 6.8 A,  $V_{DD}$  = 50 V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C
- 3. I  $_{SD} \leq$  18.5 A, di/dt  $\leq$  200 A/µs, V  $_{DD} \leq$  BV  $_{DSS},$  Starting T  $_{J}$  = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Characteristics**

Figure 1. On-Region Characteristics

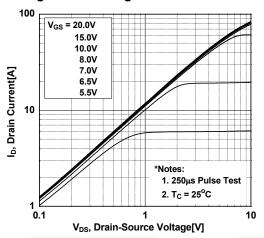


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

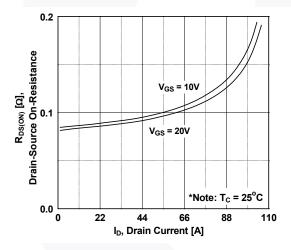


Figure 5. Capacitance Characteristics

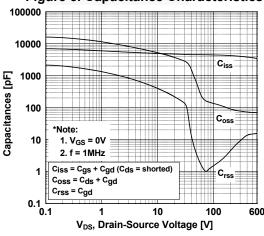


Figure 2. Transfer Characteristics

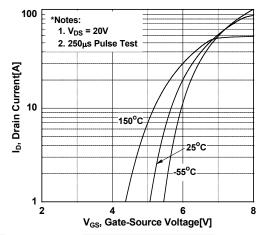


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

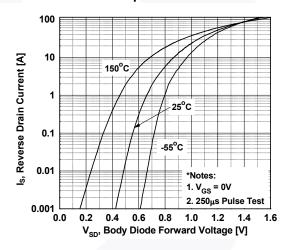
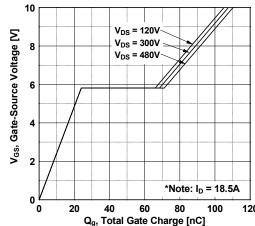


Figure 6. Gate Charge Characteristics



## **Typical Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

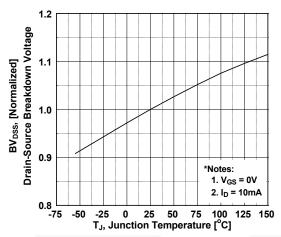


Figure 9. Maximum Safe Operating Area

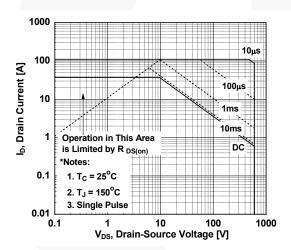


Figure 8. On-Resistance Variation vs. Temperature

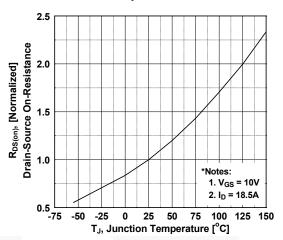
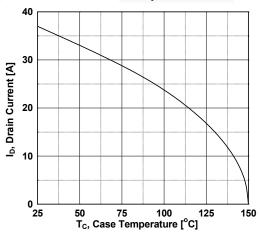


Figure 10. Maximum Drain Current vs. Case Temperature



**Figure 11. Transient Thermal Response Curve** 

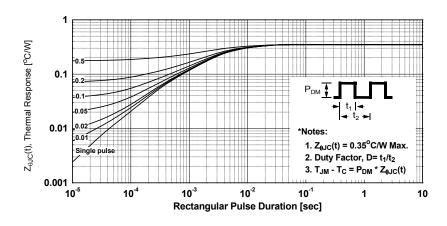


Figure 12. Gate Charge Test Circuit & Waveform

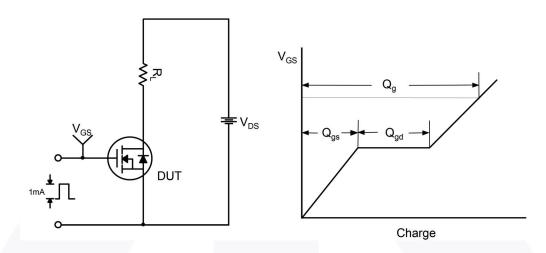


Figure 13. Resistive Switching Test Circuit & Waveforms

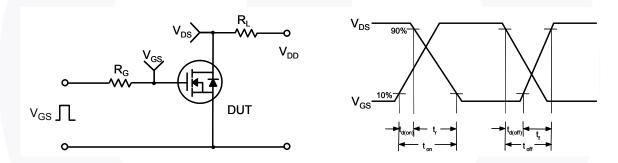
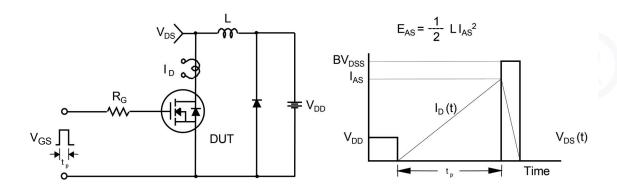


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



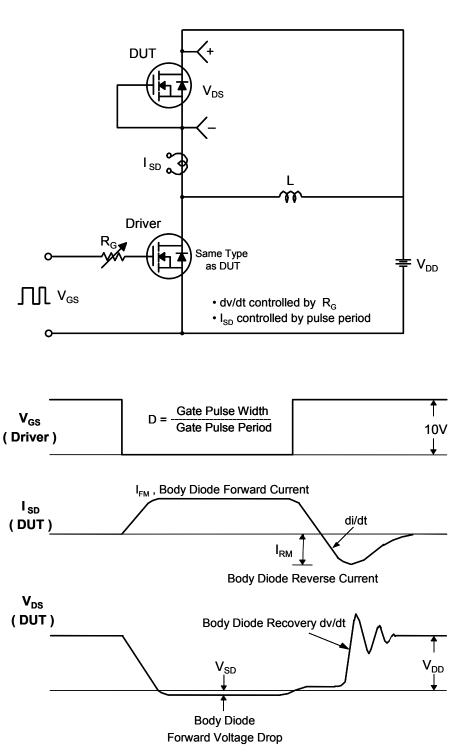


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

### **Mechanical Dimensions**

# TO-220 3L

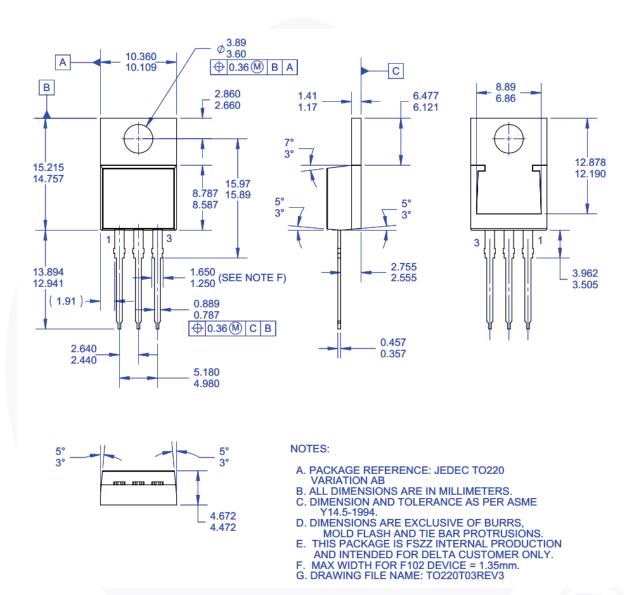


Figure 16. TO-220, Molded, 3 Lead, Jedec Variation AB (Delta)

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Dimension in Millimeters





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